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| Application/Control No. | Applicant(s)/Patent under Reexamination | |
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| 09/750,903 | KIRKBY ET AL. | |
| Examiner | Art Unit | _ |
| Hai V. Nguyen | 2142 | |

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| Class | Subclass | Date | Examiner |
| 709 | 223 | 4/8/2006 | HN |
| 370 | 230 | 4/8/2006 | HN |
| 370 | 230.1 | 4/8/2006 | HN |
| 370 | 232 | 4/8/2006 | HN |
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